Docket No.: 50090-318

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application of

shifumi TAKATA, et al.

Serial No.: 09/903,760

Group Art Unit: 2822

Filed: July 13, 2001

Examiner: J. Mitchell

For:

SEMICONDUCTOR DEVICE HAVING AN IMPROVED INTERLAYER

CONDUCTOR CONNECTIONS AND A MANUFACTURING METHOD

THEREOF

**AMENDMENT** 

Commissioner for Patents Washington, DC 20231

Sir:

The following Amendment and Remarks are submitted in reponse to the Office Action dated April 19, 2002.

## IN THE CLAIMS:

Please amend claim 9 as follows.

9. (Amended) A method of manufacturing a semiconductor device comprising the steps of:

forming a first interlayer insulating film on a semiconductor substrate;

forming a plurality of openings in said first interlayer insulating film;

forming a conductor film on said first interlayer insulating film so as to fill said openings;

WDC99 600581-1.050090.0318

F8/John HB
PATENT
PATENT
PS)/N

RECEIVED TOOL CENTER 286